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Interannual Variation in Sea Level near Truk Island—A Bimodal Seasonal Cycle

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ABSTRACT

The relationship between typical seasonal and interannual variations in Truk sea level is discussed. Periods of extreme low sea level occur episodically, at the same time that El Niño occurs in the eastern tropical Pacific. The episodes have a well-defined phase relative to the seasons and a persistence of one year. They mimic an annual cycle, but they do not repeat every year. Nevertheless, they distort the long-term mean seasonal cycle because they are very energetic. Complex demodulation shows that the amplitude of the annual oscillation is bimodal, the larger amplitude occurring during the episodes of low sea level. The phase is stable only when the amplitude is large. The amplitude and phase of the semiannual oscillation are stable; the range is approximately one-third as large as that of the interannual episodes. Thus, the seasonal cycle is bimodal in the sense that it is dominated by either the annual episode or the stable semiannual oscillation. The climate-related sea-level variation at Truk and other tropical islands is shown to be largely due to vertical displacement of the thermocline.

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